

# Ondrej Caha

## List of Publications by Year in descending order

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71  
papers

1,248  
citations

516710

16  
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395702

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g-index

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71  
docs citations

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times ranked

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#	ARTICLE	IF	CITATIONS
1	Controlling the Metamagnetic Phase Transition in FeRh/MnRh Superlattices and Thin-Film Fe <sub>50-x</sub> Mn <sub>x</sub> Rh <sub>50</sub> Alloys. ACS Applied Materials & Interfaces, 2022, 14, 3568-3579.	8.0	0
2	Photoinduced insulator-to-metal transition and coherent acoustic phonon propagation in $\text{LaCoO}_3$ thin films explored by femtosecond pump-probe ellipsometry. Physical Review B, 2022, 105, .	3.2	5
3	Tuning of SPR for Colocalized Characterization of Biomolecules Using Nanoparticle-Containing Multilayers. Plasmonics, 2021, 16, 1203-1211.	3.4	1
4	Structure Inversion Asymmetry and Rashba Effect in Quantum Confined Topological Crystalline Insulator Heterostructures. Advanced Functional Materials, 2021, 31, 2008885.	14.9	12
5	Triple-Point Fermions in Ferroelectric GeTe. Physical Review Letters, 2021, 126, 206403.	7.8	12
6	Signatures of dephasing by mirror-symmetry breaking in weak-antilocalization magnetoresistance across the topological transition in $\text{Pb}_{1-x}\text{Sn}_x\text{Se}$ . Physical Review B, 2021, 103, .	3.2	7
7	$\text{Mn}^{2+}\text{MnSb}_2\text{Te}_4$ : A Topological Insulator with Magnetic Gap Closing at High Curie Temperatures of 45–50 K. Advanced Materials, 2021, 33, e2102935.	21.0	70
8	Landau level spectroscopy of $\text{Bi}_{2-x}\text{Mn}_x\text{Te}_3$ . Physical Review B, 2020, 102, .	2.2	10
9	Evolution of strain across the magnetostructural phase transition in epitaxial FeRh films on different substrates. Physical Review B, 2020, 101, .	3.2	19
10	$\text{Mn}_3\text{Ge}$ -based tetragonal Heusler alloy thin films with addition of Ni, Pt, and Pd. Journal of Physics Condensed Matter, 2020, 32, 145801.	1.8	4
11	Step-edge assisted large scale FeSe monolayer growth on epitaxial $\text{Bi}_2\text{Se}_3$ thin films. New Journal of Physics, 2020, 22, 073050.	2.9	8
12	Fully spin-polarized bulk states in ferroelectric GeTe. Physical Review Research, 2020, 2, .	3.6	13
13	Annealing Behavior with Thickness Hindered Nucleation in Small-Molecule Organic Semiconductor Thin Films. Crystal Growth and Design, 2019, 19, 3777-3784.	3.0	2
14	Enhanced permeability dielectric FeCo/Al <sub>2</sub> O <sub>3</sub> multilayer thin films with tailored properties deposited by magnetron sputtering on silicon. AIP Advances, 2019, 9, 035243.	1.3	3
15	Large magnetic gap at the Dirac point in Bi <sub>2</sub> Te <sub>3</sub> /MnBi <sub>2</sub> Te <sub>4</sub> heterostructures. Nature, 2019, 576, 423-428.	27.8	189
16	Preparation of high-quality stress-free (001) aluminum nitride thin film using a dual Kaufman ion-beam source setup. Thin Solid Films, 2019, 670, 105-112.	1.8	11
17	Bulk polymer nanocomposites with preparation protocol governed nanostructure: the origin and properties of aggregates and polymer bound clusters. Soft Matter, 2018, 14, 2094-2103.	2.7	33
18	Direct observation of double exchange in ferromagnetic La <sub>0.7</sub> Sr <sub>0.3</sub> CoO <sub>3</sub> by broadband ellipsometry. Physical Review B, 2018, 97, .	3.2	14

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19	Determining the sub-surface damage of CdTe single crystals after lapping. Journal of Materials Science: Materials in Electronics, 2018, 29, 9652-9662.	2.2	6
20	Energy scale of Dirac electrons in Cd <sub>3</sub> As <sub>2</sub> . Physical Review B, 2018, 97, .	3.2	16
21	Nonuniform carrier density in $\text{Cd}_{1-x}\text{Te}_x$ evidenced by optical spectroscopy. Physical Review B, 2018, 97, .	2.2	22
22	Structural and Optical Properties of Luminescent Copper(I) Chloride Thin Films Deposited by Sequentially Pulsed Chemical Vapour Deposition. Coatings, 2018, 8, 369.	2.6	12
23	Structural disorder of natural $\text{Bi}_{1-x}\text{Te}_x$ superlattices grown by molecular beam epitaxy. Physical Review Materials, 2018, 2, .	2.4	10
24	Mid-infrared ellipsometry, Raman and X-ray diffraction studies of Al Ga <sup>N</sup> /AlN/Si structures. Applied Surface Science, 2017, 421, 859-865.	6.1	2
25	Topological quantum phase transition from mirror to time reversal symmetry protected topological insulator. Nature Communications, 2017, 8, 968.	12.8	31
26	Stress-free deposition of [001] preferentially oriented titanium thin film by Kaufman ion-beam source. Thin Solid Films, 2017, 638, 57-62.	1.8	5
27	Determination of the energy band gap of Bi <sub>2</sub> Se <sub>3</sub> . Scientific Reports, 2017, 7, 6891.	3.3	41
28	Temperature-dependent far-infrared reflectance of an epitaxial (BaTiO <sub>3</sub> ) <sub>8</sub> /(SrTiO <sub>3</sub> ) <sub>4</sub> superlattice. Physical Review B, 2017, 95, .	3.2	4
29	Giant Rashba Splitting in Pb <sub>1-x</sub> Sn <sub>x</sub> Te (111) Topological Crystalline Insulator Films Controlled by Bi Doping in the Bulk. Advanced Materials, 2017, 29, 1604185.	21.0	44
30	Interband absorption edge in the topological insulators $\text{Bi}_{1-x}\text{Sb}_x$ . Physical Review B, 2017, 96, .	2.2	25
31	Cyclotron resonance of Kane electrons observed in Cd <sub>3</sub> As <sub>2</sub> . , 2017, , .		0
32	Magneto-Optical Signature of Massless Kane Electrons in $\text{Cd}_{1-x}\text{Te}_x$ . Physical Review Letters, 2016, 117, 136401.	7.8	93
33	Preparation of (001) preferentially oriented titanium thin films by ion-beam sputtering deposition on thermal silicon dioxide. Journal of Materials Science, 2016, 51, 3329-3336.	3.7	17
34	Nonmagnetic band gap at the Dirac point of the magnetic topological insulator (Bi <sub>1-x</sub> Mn <sub>x</sub> ) <sub>2</sub> Se <sub>3</sub> . Nature Communications, 2016, 7, 10559.	12.8	102
35	Comparative analysis of thermal stability of two different nc-TiC/a-C:H coatings. Surface and Coatings Technology, 2015, 267, 32-39.	4.8	6
36	Structural and electronic properties of manganese-doped Bi <sub>2</sub> Te <sub>3</sub> epitaxial layers. New Journal of Physics, 2015, 17, 013028.	2.9	33

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37	Structure and composition of bismuth telluride topological insulators grown by molecular beam epitaxy. <i>Journal of Applied Crystallography</i> , 2014, 47, 1889-1900.	4.5	36
38	Study of the thermal dependence of mechanical properties, chemical composition and structure of nanocomposite TiC/a-C:H coatings. <i>Surface and Coatings Technology</i> , 2014, 242, 62-67.	4.8	9
39	Reprint of "Study of the thermal dependence of mechanical properties, chemical composition and structure of nanocomposite TiC/a-C:H coatings". <i>Surface and Coatings Technology</i> , 2014, 255, 158-163.	4.8	0
40	Raman and interband optical spectra of epitaxial layers of the topological insulators Bi <sub>2</sub> Te <sub>3</sub> and Bi <sub>2</sub> Se <sub>3</sub> on BaF <sub>2</sub> substrates. <i>Physica Scripta</i> , 2014, T162, 014007.	2.5	18
41	On the control of deposition process for enhanced mechanical properties of nc-TiC/a-C:H coatings with DC magnetron sputtering at low or high ion flux. <i>Surface and Coatings Technology</i> , 2014, 255, 8-14.	4.8	18
42	Tribological properties of nc-TiC/a-C:H coatings prepared by magnetron sputtering at low and high ion bombardment of the growing film. <i>Surface and Coatings Technology</i> , 2014, 241, 64-73.	4.8	12
43	Growth, Structure, and Electronic Properties of Epitaxial Bismuth Telluride Topological Insulator Films on BaF <sub>2</sub> (111) Substrates. <i>Crystal Growth and Design</i> , 2013, 13, 3365-3373.	3.0	70
44	Humidity resistant hydrogenated carbon nitride films. <i>Applied Surface Science</i> , 2013, 275, 7-13.	6.1	2
45	Lattice constants and optical response of pseudomorph Si-rich SiGe:B. <i>Applied Physics Letters</i> , 2013, 103, 202107.	3.3	1
46	Nucleation of lateral compositional modulation in InGaP epitaxial films grown on (001) GaAs. <i>Journal of Applied Physics</i> , 2012, 111, 024306.	2.5	4
47	Evaluation of composition, mechanical properties and structure of nc-TiC/a-C:H coatings prepared by balanced magnetron sputtering. <i>Surface and Coatings Technology</i> , 2012, 211, 111-116.	4.8	27
48	Precipitation in silicon wafers after high temperature preanneal studied by X-ray diffraction methods. <i>Physica B: Condensed Matter</i> , 2012, 407, 3002-3005.	2.7	0
49	Complementary information on CdSe/ZnSe quantum dot local structure from extended X-ray absorption fine structure and diffraction anomalous fine structure measurements. <i>Journal of Alloys and Compounds</i> , 2012, 523, 155-160.	5.5	13
50	Studies of influence of high temperature preannealing on oxygen precipitation in CZ Si wafers. <i>Journal of Crystal Growth</i> , 2012, 348, 53-59.	1.5	9
51	Surface morphology and magnetic anisotropy in (Ga,Mn)As. <i>Applied Physics Letters</i> , 2011, 98, 152503.	3.3	10
52	InAs/GaAs quantum dot capping in kinetically limited MOVPE growth regime. <i>Journal of Crystal Growth</i> , 2011, 317, 39-42.	1.5	2
53	Study of oxide precipitates in silicon using X-ray diffraction techniques. <i>Physica Status Solidi (A) Applications and Materials Science</i> , 2011, 208, 2587-2590.	1.8	2
54	Optical characterization of HfO <sub>2</sub> thin films. <i>Thin Solid Films</i> , 2011, 519, 6085-6091.	1.8	32

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55	InGaAs and GaAsSb strain reducing layers covering InAs/GaAs quantum dots. Journal of Crystal Growth, 2010, 312, 1383-1387.	1.5	17
56	Plasma polymer films of tetravinylsilane modified by UV irradiation. Surface and Coatings Technology, 2010, 205, S177-S181.	4.8	5
57	Density of Mn interstitials in (Ga,Mn)As epitaxial layers determined by anomalous x-ray diffraction. Applied Physics Letters, 2010, 97, .	3.3	6
58	Effect of strain on the growth of InAs/GaSb superlattices: An x-ray diffraction study. Journal of Applied Physics, 2010, 107, .	2.5	13
59	Analysis of vacancy and interstitial nucleation kinetics in Si wafers during rapid thermal annealing. Journal of Physics Condensed Matter, 2009, 21, 105402.	1.8	3
60	Vacancies and Self-Interstitials Dynamics in Silicon Wafers. Solid State Phenomena, 2009, 156-158, 139-144.	0.3	1
61	Interdiffusion in Ge rich SiGe/Ge multilayers studied by <i>in situ</i> diffraction. Physica Status Solidi (A) Applications and Materials Science, 2009, 206, 1775-1779.	1.8	10
62	X-ray diffraction on precipitates in Czochralski-grown silicon. Physica B: Condensed Matter, 2009, 404, 4626-4629.	2.7	5
63	Homogenization of CZ Si wafers by Tabula Rasa annealing. Physica B: Condensed Matter, 2009, 404, 4637-4640.	2.7	5
64	Development of oxide precipitates in silicon: calculation of the distribution function of the classical theory of nucleation by a nodal-points approximation. Journal of Physics Condensed Matter, 2007, 19, 496202.	1.8	6
65	Nonlinear Evolution of Surface Morphology in InAs/AlAs Superlattices via Surface Diffusion. Physical Review Letters, 2006, 96, 136102.	7.8	8
66	Morphological Instability in InAs/GaSb Superlattices due to Interfacial Bonds. Physical Review Letters, 2005, 95, 096104.	7.8	14
67	Spontaneous lateral modulation in short-period superlattices investigated by grazing-incidence x-ray diffraction. Physical Review B, 2005, 72, .	3.2	2
68	X-ray diffraction on laterally modulated (InAs) $n$ $\cdot$ (AlAs) $m$ short-period superlattices. Journal of Applied Physics, 2004, 96, 4833-4838.	2.5	5
69	Effect of Hydrogen on the Properties of Amorphous Carbon Nitride Films. Advanced Materials Research, 0, 383-390, 3298-3304.	0.3	2
70	Homogeneous and Heterogeneous Nucleation of Oxygen in Si-CZ. Solid State Phenomena, 0, 178-179, 495-500.	0.3	0
71	Oxygen Precipitation Studied by X-Ray Diffraction Techniques. Solid State Phenomena, 0, 178-179, 325-330.	0.3	0